

LINEAR INTEGRATED CIRCUITS

DESCRIPTION

The NE528B is a monolithic four channel plated wire sense amplifier designed to read small signals, 3mV or above, and translate them to TTL logic levels. The NE528B features input channel selection by means of three TTL channel select inputs, one of which allows for total input disable. The output is TTL compatible and can be used in the "WIRED-OR" configuration.

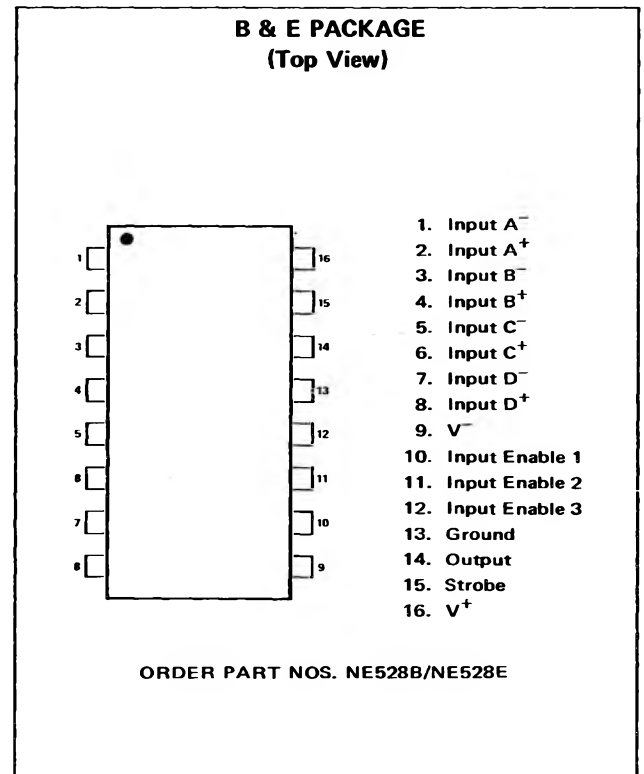
FEATURES

- FOUR CHANNELS IN ONE PACKAGE
- TOTAL INPUT DISABLE PROVIDED
- 16mA SINK CAPABILITY
- OUTPUT STRUCTURE ALLOWS FOR WIRED-OR, PARALLELING
- CHANNEL SELECT, STROBE AND OUTPUT TTL COMPATIBLE

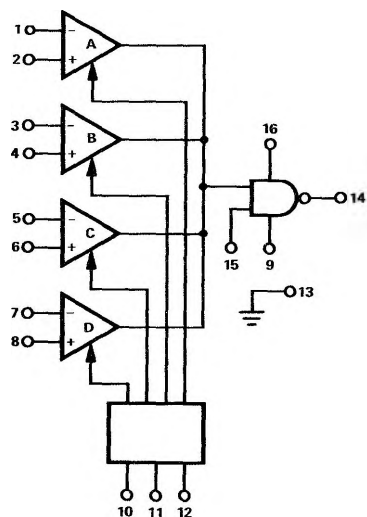
ABSOLUTE MAXIMUM RATINGS

Supply Voltage	±10V
Strobe Control Voltage	+6V
Differential Input Voltage	±5V
Amplifier Input Current	2mA
Common Mode Input Voltage	+5 to -6V
Storage Temperature Range	-65°C to +150°C
Operating Temperature Range	0°C to 70°C

PIN CONFIGURATION



LOGIC DIAGRAM AND TRUTH TABLE

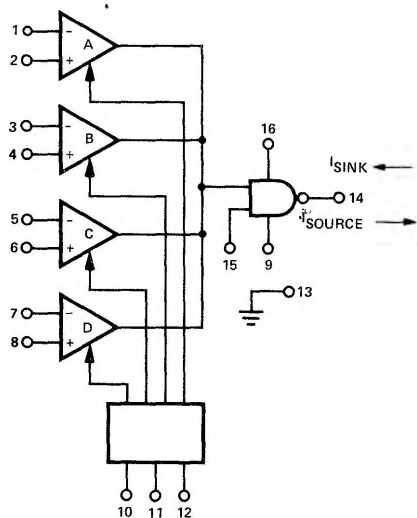


Amplifier Activated	Enable Input 1	Enable Input 2	Enable Input 3
A	0	0	1
B	1	0	1
C	1	1	1
D	0	1	1
NONE	X	X	0

x = DON'T CARE

ELECTRICAL CHARACTERISTICS (Conditions: $V^+ = 5V$, $V^- = -6V$, $T_A = 25^\circ$ unless specified)

PARAMETERS	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Input Bias Current	$V^+ = 5.25V$, $V^- = -6.3V$, $V_{in} = 0$		15	50	μA
Input Offset Current	$V^+ = 5.25V$, $V^- = -6.3V$, $V_{in} = 0$		0.5	5	μA
Differential Input Threshold Voltage	Figure 1	-3		+3	mV
Output Voltage					
"1" State	$V^+ = 4.75V$	2.4			V
"0" State	$V^+ = 5.25V$			0.4	V
Enable and Strobe Inputs					
"0" Input Current	$V^+ = 5.25V$, $V^- = -6.3V$, $V_{in} = 0.4V$			-1.6	mA
"1" Input Current	$V^+ = 5.25V$, $V^- = -6.3V$, $V_{in} = 2.4V$			40	μA
"0" Input Voltage	$V^+ = 4.75V$, $V^- = -5.7V$			0.8	V
"1" Input Voltage	$V^+ = 4.75V$, $V^- = -5.7V$	2.0			V
Power Consumption	$V^+ = 5.25V$, $V^- = -6.3V$			270	mW
Positive Supply Current	$V^+ = 5.25V$, $V^- = -6.3V$			35	mA
Negative Supply Current	$V^+ = 5.25V$, $V^- = -6.3V$			15	mA
Input Resistance	$f = 1 \text{ kHz}$		2K		Ω
Propagation Delay	Unused Inputs Grounded, Figure 2				
$t_{pd} (0)$			20		nsec
$t_{pd} (1)$			25		nsec
Output Rise Time	Figure 3		16		nsec
Output Fall Time	Figure 3		6		nsec
Strobe Delay Time	Figure 2				
Turn On			10		nsec
Turn Off			12		nsec
Channel Select Time	Figure 3		9		nsec
Total Disable to Enable Time	Figure 2		25		nsec
Enable to Total Disable Time	Figure 2		28		nsec

LOGIC DIAGRAM AND TEST TABLE ($V^+ = 5V$, $V^- = -6V$, $T_A = 25^\circ C$)**FIGURE 1**

Pin 10	Pin 11	Pin 12	Pin 15	Enabled Inputs	V_{in}	V_{out}	I_{Sink}	I_{Source}
0	0	1	1	1-2	3mV	$\leq 0.4V$	16mA	
0	0	1	1	1-2	-3mV	$\geq 2.4V$		-400 μA
0	0	1	1	2-1	3mV	$\geq 2.4V$		-400 μA
0	0	1	1	2-1	-3mV	$\leq 0.4V$	16mA	
1	0	1	1	3-4	3mV	$\leq 0.4V$	16mA	
1	0	1	1	3-4	-3mV	$\geq 2.4V$		-400 μA
1	0	1	1	4-3	3mV	$\geq 2.4V$		-400 μA
1	0	1	1	4-3	-3mV	$\leq 0.4V$	16mA	
1	1	1	1	5-6	3mV	$\leq 0.4V$	16mA	
1	1	1	1	5-6	-3mV	$\geq 2.4V$		-400 μA
1	1	1	1	6-5	3mV	$\geq 2.4V$		-400 μA
1	1	1	1	6-5	-3mV	$\leq 0.4V$	16mA	
0	1	1	1	7-8	3mV	$\leq 0.4V$	16mA	
0	1	1	1	7-8	-3mV	$\geq 2.4V$		-400 μA
0	1	1	1	8-7	3mV	$\geq 2.4V$		-400 μA
0	1	1	1	8-7	-3mV	$\leq 0.4V$	16mA	
X	X	X	0	X	X	$\geq 2.4V$		-400 μA
X	X	0	X	X	X	$\geq 2.4V$		-400 μA

TEST FIGURE AND WAVEFORMS

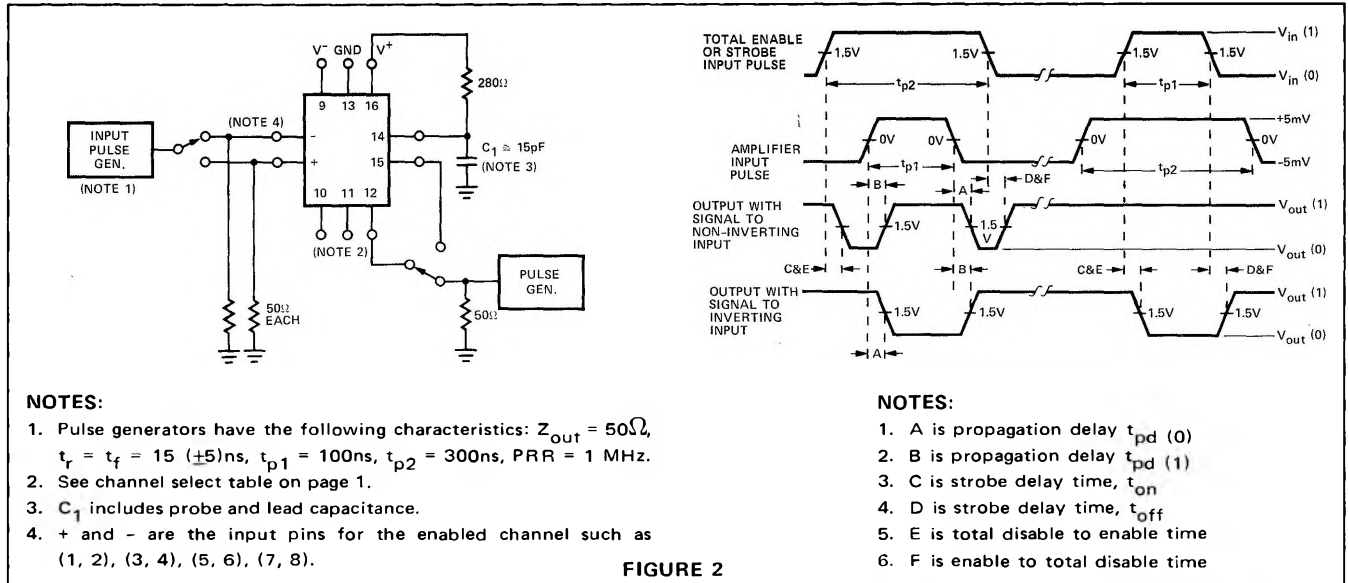


FIGURE 2

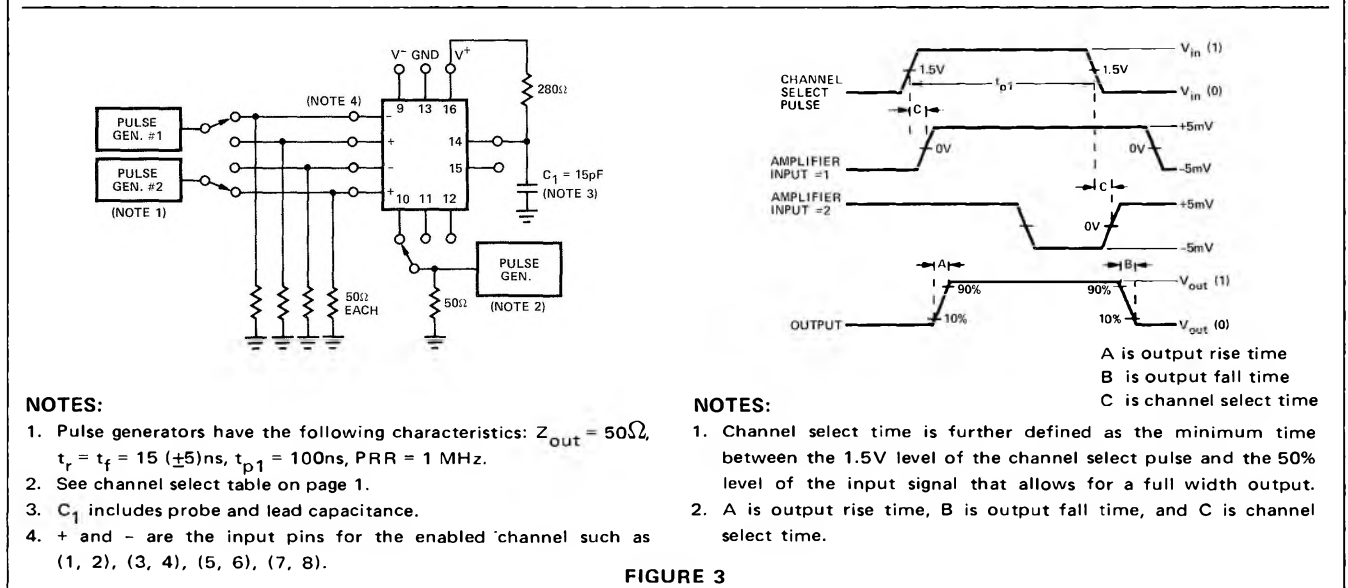
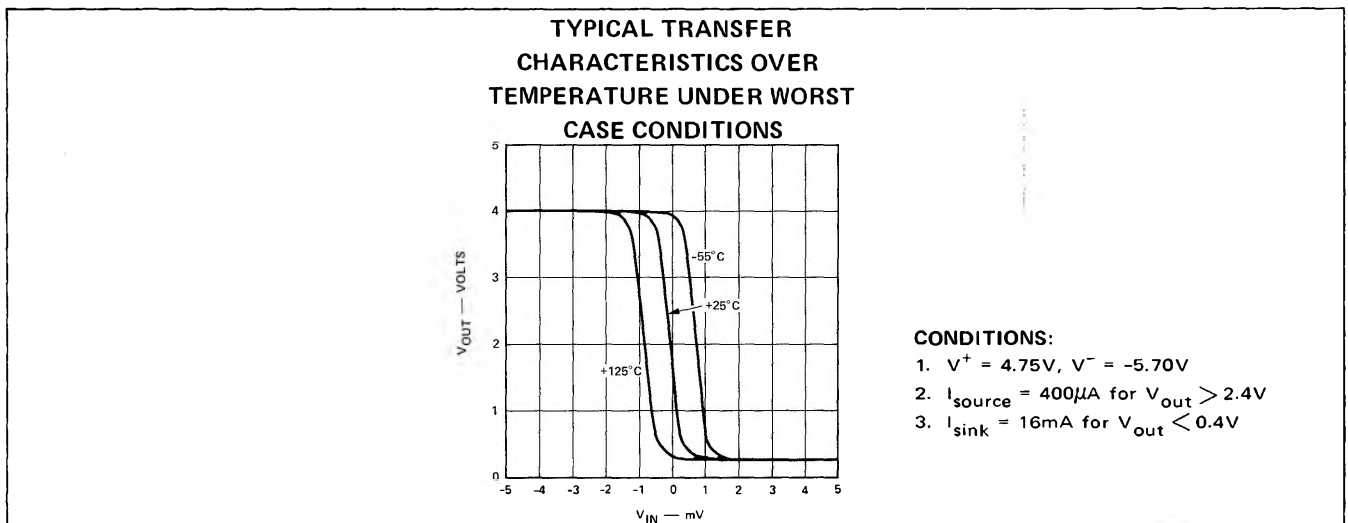


FIGURE 3

TYPICAL CHARACTERISTIC CURVE



EQUIVALENT SCHEMATIC DIAGRAM

